PHKD6N02LT

Dual N-channel TrenchMOS logic level FET

Rev. 04 — 27 April 2010

Product data sheet

1. Product profile

1.1 General description

Dual logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Suitable for logic level gate drive sources

1.3 Applications

- Battery chargers
- DC-to-DC convertors

- Notebook computers
- Portable equipment

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-	20	V		
I _D	drain current	T _{sp} = 25 °C; Single device conducting; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	-	10.9	Α		
P _{tot}	total power dissipation	T _{sp} = 25 °C; see <u>Figure 2</u>	-	-	4.17	W		
Static chara	acteristics							
R _{DSon}	drain-source on-state resistance	$V_{GS} = 2.5 \text{ V}; I_D = 3 \text{ A}; T_j = 25 \text{ °C}$	-	25	35	mΩ		
Dynamic ch	Dynamic characteristics							
Q_{GD}	gate-drain charge	$V_{GS} = 5 \text{ V}; I_D = 6 \text{ A}; V_{DS} = 16 \text{ V};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 11}}{\text{ V}}$	-	6	-	nC		



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source1		D. D. D. D. D.
2	G1	gate1	8 <u> </u>	D1 D1 D2 D2
3	S2	source2		
4	G2	gate2		
5	D2	drain2	1	
6	D2	drain2	SOT96-1 (SO8)	S1 G1 S2 G2
7	D1	drain1		mbk725
8	D1	drain1		

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PHKD6N02LT	SO8	plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-	20	V
V_{DGR}	drain-gate voltage	$T_j \le 150 \text{ °C}; T_j \ge 25 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	-	20	V
V _{GS}	gate-source voltage		-12	-	12	V
I _D	drain current	T _{sp} = 100 °C; Single device conducting; see <u>Figure 1</u>	-	-	6.8	Α
		T _{sp} = 25 °C; Single device conducting; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	-	10.9	Α
I _{DM}	peak drain current	T_{sp} = 25 °C; $t_p \le 100 \ \mu s$; pulsed; Single device conducting; see Figure 3	-	-	44	А
P _{tot}	total power dissipation	T _{sp} = 25 °C; see <u>Figure 2</u>	-	-	4.17	W
T _{stg}	storage temperature		-55	-	150	°C
Tj	junction temperature		-55	-	150	°C
Source-drain	diode					
Is	source current	T _{sp} = 25 °C	-	-	3.5	Α
I _{SM}	peak source current	T_{sp} = 25 °C; $t_p \le 10 \mu s$; pulsed	-	-	44	Α

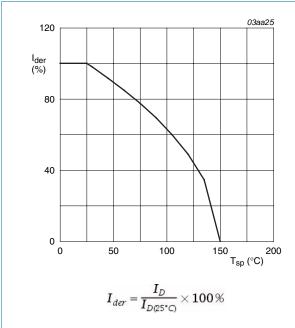


Fig 1. Normalized continuous drain current as a function of solder point temperature

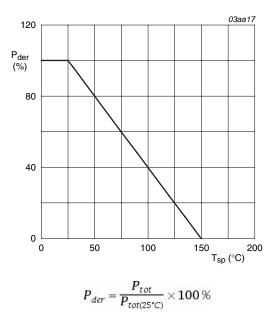
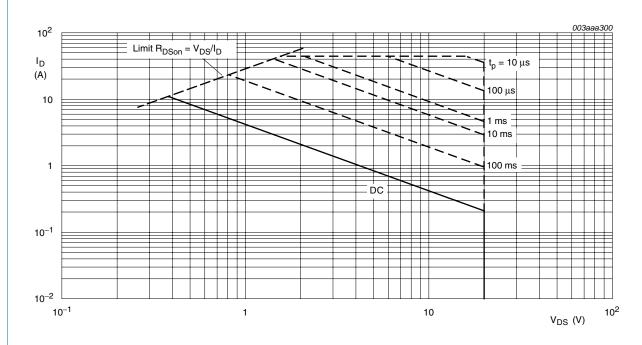


Fig 2. Normalized total power dissipation as a function of solder point temperature



 $T_{sp} = 25^{\circ}C; I_{DM}$ is single pulse;

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage



5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	see Figure 4	-	-	30	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	minimum footprint; mounted on printed-circuit board	-	70	-	K/W

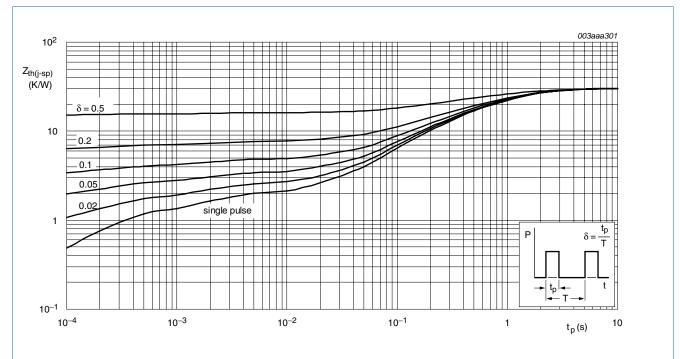


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration

6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	20	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 250 \mu A; V_{DS} = 10 V; T_j = 25 °C;$ see <u>Figure 8</u>	0.5	-	1.5	V
I _{DSS}	drain leakage current	$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μΑ
		$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	-	500	μΑ
I _{GSS}	gate leakage current	$V_{GS} = 12 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	100	nA
		$V_{GS} = -12 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	100	nA
R _{DSon}	drain-source on-state	$V_{GS} = 2.5 \text{ V}; I_D = 3 \text{ A}; T_j = 25 ^{\circ}\text{C}$	-	25	35	mΩ
	resistance	$V_{GS} = 5 \text{ V}; I_D = 3 \text{ A}; T_j = 150 °C;$ see <u>Figure 9</u> ; see <u>Figure 10</u>	-	-	35	mΩ
		$V_{GS} = 5 \text{ V}$; $I_D = 3 \text{ A}$; $T_j = 25 \text{ °C}$; see <u>Figure 9</u> ; see <u>Figure 10</u>	-	16	20	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 6 \text{ A}$; $V_{DS} = 16 \text{ V}$; $V_{GS} = 5 \text{ V}$; $T_j = 25 \text{ °C}$;	-	15.3	-	nC
Q_{GS}	gate-source charge	see Figure 11	-	2.2	-	nC
Q_{GD}	gate-drain charge		-	6	-	nC
C _{iss}	input capacitance	$V_{DS} = 10 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}; T_j = 25 ^{\circ}\text{C};$	-	950	-	pF
Coss	output capacitance	see Figure 12	-	355	-	pF
C _{rss}	reverse transfer capacitance		-	256	-	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 10 \text{ V}; R_L = 3.3 \Omega; V_{GS} = 5 \text{ V};$	-	15	-	ns
t _r	rise time	$R_{G(ext)} = 4.7 \Omega; T_j = 25 °C$	-	49	-	ns
t _{d(off)}	turn-off delay time		-	50	-	ns
t _f	fall time		-	23	-	ns
Source-d	rain diode					
V_{SD}	source-drain voltage	$I_S = 6 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 13}{\text{ Figure } 13}$	-	-	1.2	V
t _{rr}	reverse recovery time	$I_S = 6 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$	-	40	-	ns
Q _r	recovered charge	$V_{DS} = 20 \text{ V}; T_j = 25 \text{ °C}$	-	7	-	nC

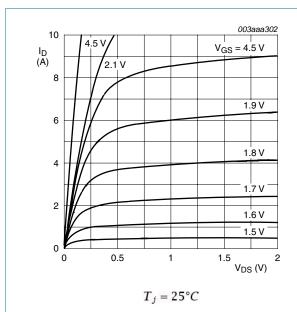


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

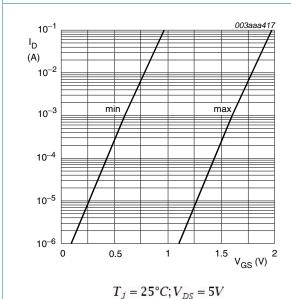
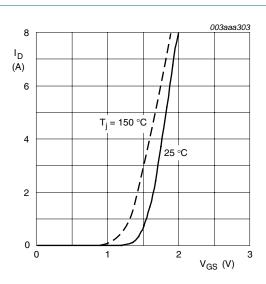


Fig 7. Sub-threshold drain current as a function of gate-source voltage



 $T_j = 25^{\circ}C$ and $150^{\circ}C$; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values

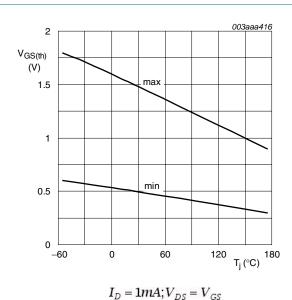


Fig 8. Gate-source threshold voltage as a function of

junction temperature

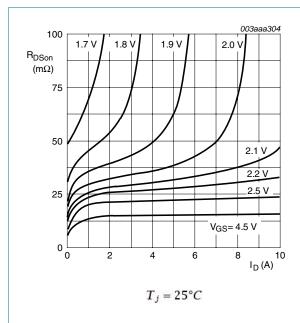


Fig 9. Drain-source on-state resistance as a function of drain current; typical values

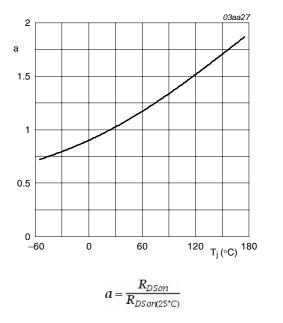


Fig 10. Normalized drain-source on-state resistance factor as a function of junction temperature

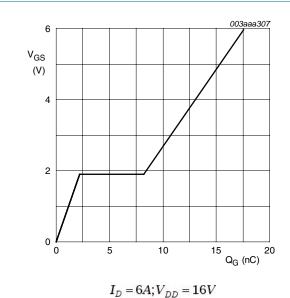
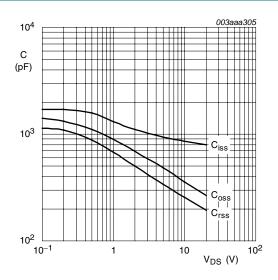
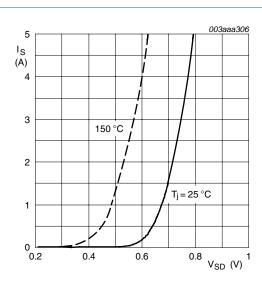


Fig 11. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0V; f = 1MHz$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical val



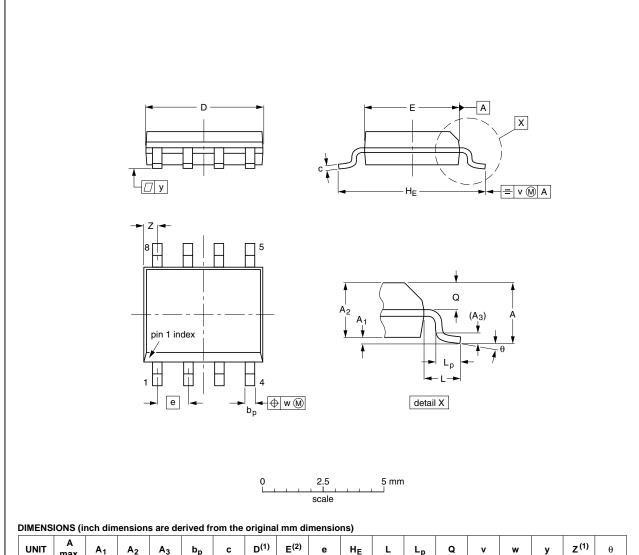
 $T_j = 25^{\circ}C \text{ and } 150^{\circ}C; V_{GS} = 0V$

Fig 13. Source current as a function of source-drain voltage; typical values

7. Package outline

SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽²⁾	e	HE	٦	Lp	q	v	w	у	z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	5.0 4.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075	0.20 0.19	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.
- 2. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

	REFER	EUROPEAN	ISSUE DATE		
IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
076E03	MS-012				99-12-27 03-02-18
		IEC JEDEC	IEC JEDEC JEITA	IEC JEDEC JEITA	IEC JEDEC JEITA PROJECTION

Fig 14. Package outline SOT96-1 (SO8)

PHKD6N02LT

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8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PHKD6N02LT_4	20100427	Product data sheet	-	PHKD6N02LT_3
Modifications:	 Various cha 	anges to content.		
PHKD6N02LT_3	20091119	Product data sheet	-	PHKD6N02LT-02
PHKD6N02LT-02	20030812	Product data	-	PHKD6N02LT-01
PHKD6N02LT-01	20010907	Product data	-	-

9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
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